





#### **60V N-CHANNEL ENHANCEMENT MODE MOSFET**

### **Product Summary**

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> Max	I <sub>D</sub> T <sub>A</sub> = +25°C
601/	44mΩ @ V <sub>GS</sub> = 10V	5.0A
60V	60mΩ @ V <sub>GS</sub> = 4.5V	4.3A

### **Features and Benefits**

- 100% Unclamped Inductive Switch (UIS) Test in Production
- Low Input Capacitance
- Low On-Resistance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 standards for High Reliability
- PPAP Capable (Note 4)

### **Description and Applications**

This new generation MOSFET is designed to minimize the on-state resistance (R<sub>DS(ON)</sub>), yet maintain superior switching performance, making it ideal for high efficiency power management applications.

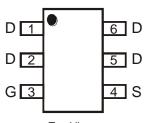
- DC-DC Converters
- Power Management Functions
- Backlighting

### **Mechanical Data**

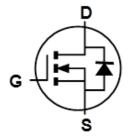
- Case: TSOT26
- Case Material: Molded Plastic, "Green" Molding Compound.
   UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Tin Finish Annealed over Copper Leadframe.
   Solderable per MIL-STD-202, Method 208 (§3)
- Weight: 0.013 grams (Approximate)







Top View Pin Configuration



**Equivalent Circuit** 

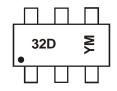
### **Ordering Information** (Note 5)

Part Number	Case	Packaging
DMN6040SVTQ-7	TSOT26	3,000/Tape & Reel
DMN6040SVTQ-13	TSOT26	10,000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. Automotive products are AEC-Q101 qualified and are PPAP capable. Please refer to http://www.diodes.com/quality/product\_compliance\_definitions/.
- 5. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

# Marking Information



32D = Product Type Marking Code YM = Date Code Marking Y = Year (ex: X = 2010) M = Month (ex: 9 = September)

Date Code Key

Year	2010		2017	2018	3 20°	19 2	020	2021	2022	2023	2024	2025
Code	Х		Е	F	G	i	Н	I	J	K	L	М
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



# **Maximum Ratings** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

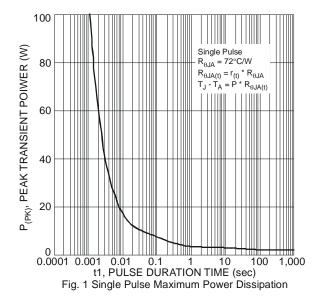
Characteristic	Symbol	Value	Units		
Drain-Source Voltage	$V_{DSS}$	60	V		
Gate-Source Voltage	$V_{GSS}$	±20	V		
Continuous Drain Current (Note 7) V 40V	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I <sub>D</sub>	5.0 4.0	А	
Continuous Drain Current (Note 7) V <sub>GS</sub> = 10V	t<10s	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I <sub>D</sub>	6.3 5.0	А
Continuous Drain Compant (Note 7) V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I <sub>D</sub>	4.3 3.4	А
Continuous Drain Current (Note 7) V <sub>GS</sub> = 5V	t<10s	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I <sub>D</sub>	5.4 4.3	А
Maximum Body Diode Forward Current (Note 7)	Is	2.1	Α		
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)	I <sub>DM</sub>	30	Α		
Avalanche Current (Note 8) L = 0.1mH	I <sub>AR</sub>	14.2	Α		
Avalanche Energy (Note 8) L = 0.1mH	E <sub>AR</sub>	10	mJ		

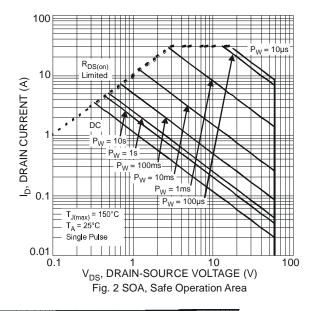
# Thermal Characteristics (@ $T_A = +25^{\circ}C$ , unless otherwise specified.)

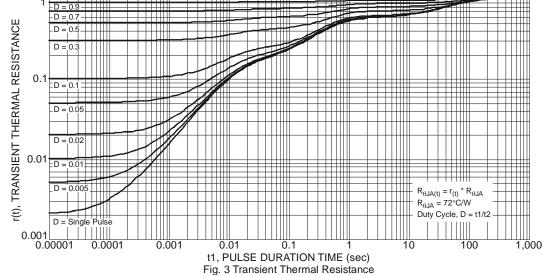
Characteristic	Symbol	Value	Units		
Total Power Dissipation (Note 6)	$T_A = +25^{\circ}C$	C	1.2	W	
Total Power Dissipation (Note 6)	$T_A = +70^{\circ}C$	$P_{D}$	0.75	۷V	
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	D	106	°C/W	
Thermal Resistance, Junction to Ambient (Note o)	t<10s	$R_{\theta JA}$	69	°C/W	
Total Power Dissipation (Note 7)	$T_A = +25^{\circ}C$	C	1.8	W	
Total Power Dissipation (Note 7)	$T_A = +70^{\circ}C$	$P_{D}$	1.1		
Thermal Resistance, Junction to Ambient (Note 7)	Steady State	0	68	°C/W	
Thermal Resistance, Junction to Ambient (Note 7)	t<10s	$R_{\theta JA}$	44	°C/W	
Thermal Resistance, Junction to Case (Note 7)		$R_{ heta JC}$	20	°C/W	
Operating and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C	

- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout. 7. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
- 8. IAR and EAR rating are based on low frequency and duty cycles to keep  $T_J = +25$ °C.











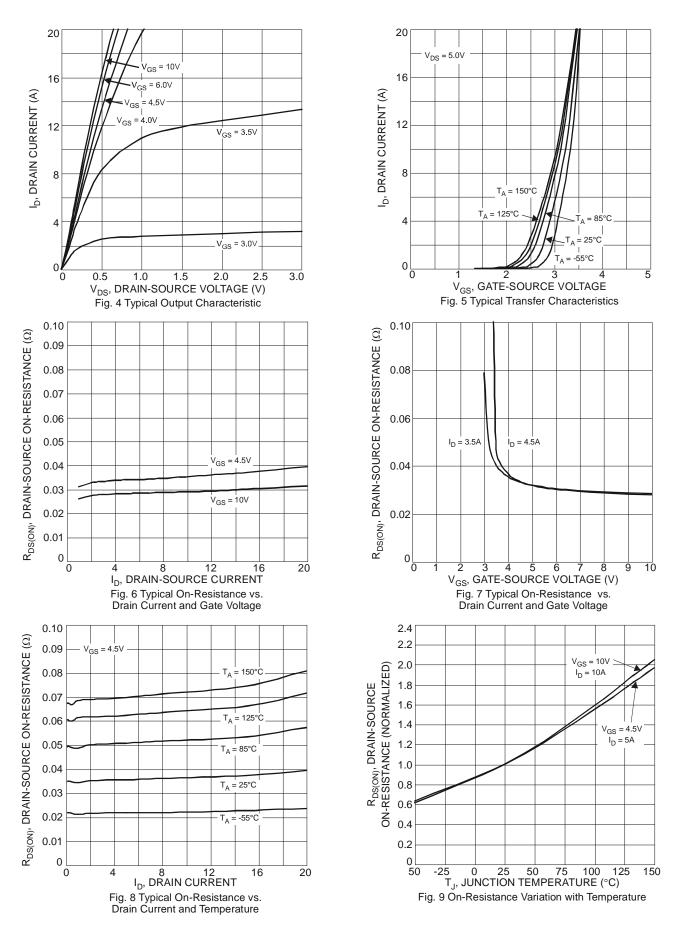
# Electrical Characteristics @TA = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 9)					•	
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	60	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	100	nA	$V_{DS} = 60V, V_{GS} = 0V$
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 9)						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	1		3	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
Static Drain-Source On-Resistance			30	44	mΩ	$V_{GS} = 10V, I_D = 4.3A$
Static Diain-Source Off-Resistance	R <sub>DS(ON)</sub>		35	60	11152	$V_{GS} = 4.5V, I_D = 4A$
Forward Transfer Admittance	Y <sub>FS</sub>		4.5	_	S	$V_{DS} = 10V, I_D = 4.3A$
Diode Forward Voltage	$V_{SD}$	_	0.7	1.2	V	$V_{GS} = 0V, I_{S} = 1A$
DYNAMIC CHARACTERISTICS (Note 10)						
Input Capacitance	CISS		1,287	_		V 05V V 0V
Output Capacitance	Coss		57	_	pF	$V_{DS} = 25V, V_{GS} = 0V$ f = 1.0MHz
Reverse Transfer Capacitance	C <sub>RSS</sub>		44	_		1 = 1.0IVII IZ
Gate Resistance	Rg	_	1.2	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$
Total Gate Charge (V <sub>GS</sub> = 10V)	$Q_G$	_	22.4			
Total Gate Charge (V <sub>GS</sub> = 4.5V)	$Q_G$	_	10.4	_	nC	V 20V L 42A
Gate-Source Charge	Q <sub>GS</sub>	_	4.9	_	IIC	$V_{DS} = 30V, I_{D} = 4.3A$
Gate-Drain Charge	$Q_{GD}$	_	3.0	_		
Turn-On Delay Time	t <sub>D(ON)</sub>	_	6.6			
Turn-On Rise Time	t <sub>R</sub>	_	8.1	_		$V_{GS} = 10V, V_{DD} = 30V, R_G = 6\Omega,$
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	20.1		ns	$I_D = 4.3A$
Turn-Off Fall Time	t <sub>F</sub>		4.0			
Body Diode Reverse Recovery Time	t <sub>RR</sub>	_	18		ns	I <sub>S</sub> = 4.3A, dI/dt = 100A/µs
Body Diode Reverse Recovery Charge	Q <sub>RR</sub>	_	11.9		nC	I <sub>S</sub> = 4.3A, dl/dt = 100A/µs

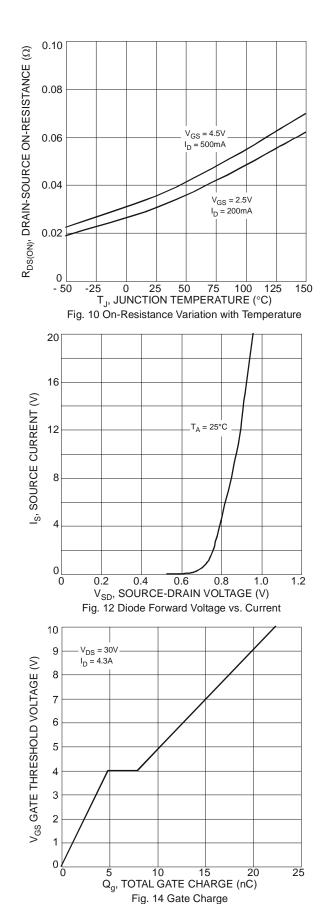
Notes:

<sup>9.</sup> Short duration pulse test used to minimize self-heating effect. 10. Guaranteed by design. Not subject to product testing.









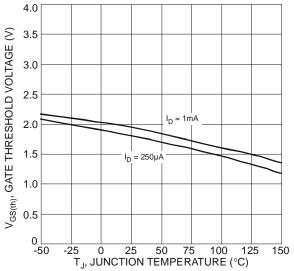
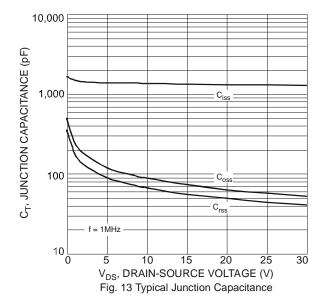


Fig. 11 Gate Threshold Variation vs. Ambient Temperature

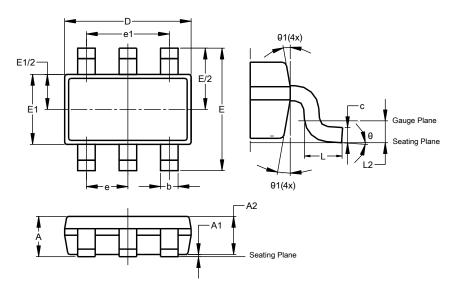




# **Package Outline Dimensions**

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.

#### TSOT26

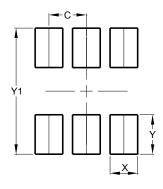


TSOT26								
Dim	Min	Max	Тур					
Α	-	1.00	-					
A1	0.010	0.100	_					
A2	0.840	0.900	-					
D	2.800	3.000	2.900					
Е	2	2.800 BSC						
E1	1.500	1.700	1.600					
b	0.300	0.450	-					
С	0.120	0.200	_					
е	0.950 BSC							
e1	1	1.900 BSC						
L	0.30	0.50						
L2	0.250 BSC							
θ	0°	8°	4°					
θ1	4°	12°	_					
All Dimensions in mm								

# Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.

### TSOT26



Dimensions	Value (in mm)
С	0.950
Х	0.700
Υ	1.000
Y1	3.199



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